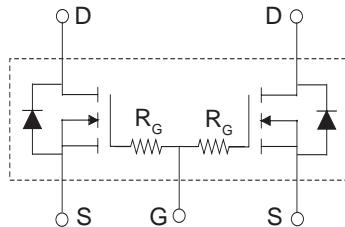


TrenchMV™
Power MOSFETs
Common-Gate Pair
(Electrically Isolated Back Surface)

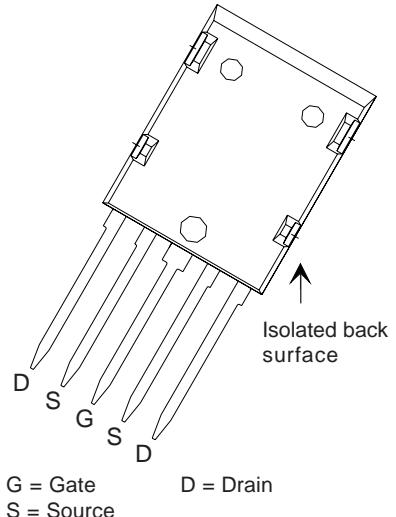
N-Channel Enhancement Mode
Avalanche Rated

IXTL2x200N085T

$V_{DSS} = 85 \text{ V}$
 $I_{D25} = 2 \times 112 \text{ A}$
 $R_{DS(on)} \leq 6.0 \text{ m}\Omega$



ISOPLUS i5-Pak™(IXTL)



Symbol	Test Conditions	Maximum Ratings	
V_{DSS}	$T_J = 25^\circ\text{C}$ to 175°C	85	V
V_{DGR}	$T_J = 25^\circ\text{C}$ to 175°C ; $R_{GS} = 1 \text{ M}\Omega$	85	V
V_{GSM}	Transient	± 20	V
I_{D25}	$T_c = 25^\circ\text{C}$ (Combined die total = 224 A)	112	A
I_{LRMS}	Package Current Limit, RMS (Combined die total = 150 A)	75	A
I_{DM}	$T_c = 25^\circ\text{C}$, pulse width limited by T_{JM}	540	A
I_{AR}	$T_c = 25^\circ\text{C}$	25	A
E_{AS}	$T_c = 25^\circ\text{C}$	1.0	J
dv/dt	$I_s \leq I_{DM}$, $di/dt \leq 100 \text{ A}/\mu\text{s}$, $V_{DD} \leq V_{DSS}$ $T_J \leq 175^\circ\text{C}$, $R_G = 5 \Omega$	3	V/ns
P_D	$T_c = 25^\circ\text{C}$	150	W
T_J		-55 ... +175	°C
T_{JM}		175	°C
T_{stg}		-55 ... +175	°C
T_L	1.6 mm (0.062 in.) from case for 10 s	300	°C
T_{SOLD}	Plastic body for 10 seconds	260	°C
V_{ISOL}	50/60 Hz, $t = 1$ minute, $I_{ISOL} < 1 \text{ mA}$, RMS	2500	V
F_c	Mounting force	20..120/4.5..25	N/lb.
Weight		9	g

Symbol	Test Conditions	Characteristic Values		
	($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
BV_{DSS}	$V_{GS} = 0 \text{ V}$, $I_D = 250 \mu\text{A}$	85		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$	2.0		4.0 V
I_{GSS}	$V_{GS} = \pm 20 \text{ V}$, $V_{DS} = 0 \text{ V}$			$\pm 200 \text{ nA}$
I_{DSS}	$V_{DS} = V_{DSS}$ $V_{GS} = 0 \text{ V}$			5 μA 250 μA
$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$, $I_D = 50 \text{ A}$, Notes 1, 2			6.0 $\text{m}\Omega$

All ratings and parametric values are per each MOSFET die unless otherwise specified.

Symbol	Test Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
g_{fs}	$V_{DS} = 10 \text{ V}; I_D = 60 \text{ A}$, Note 1	75	125	S	
R_G			3	Ω	
C_{iss}		7600		pF	
C_{oss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	1040		pF	
C_{rss}		200		pF	
$t_{d(on)}$		32		ns	
t_r	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 25 \text{ A}$	80		ns	
$t_{d(off)}$	$R_G = 5 \Omega$ (External)	65		ns	
t_f		64		ns	
$Q_{g(on)}$		152		nC	
Q_{gs}	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 V_{DSS}, I_D = 25 \text{ A}$	37		nC	
Q_{gd}		42		nC	
R_{thJC}			1.0	$^\circ\text{C}/\text{W}$	
R_{thCS}		0.50		$^\circ\text{C}/\text{W}$	

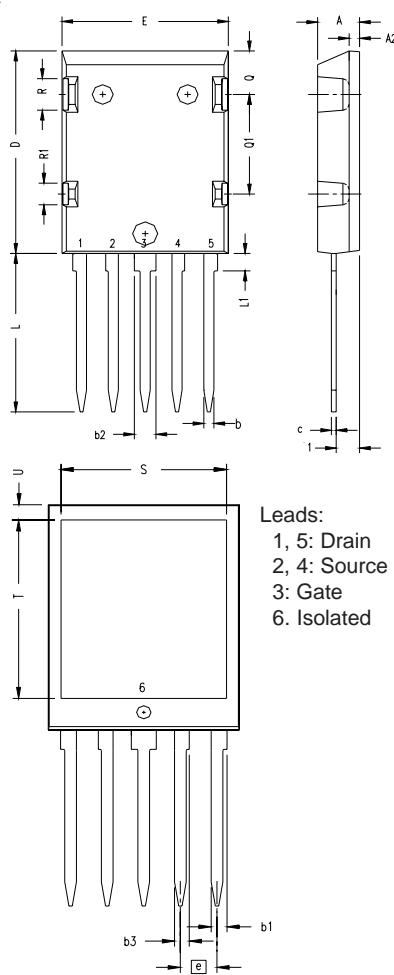
Source-Drain Diode

Symbol	Test Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$ unless otherwise specified)	Min.	Typ.	Max.
I_s	$V_{GS} = 0 \text{ V}$		200	A	
I_{SM}	Pulse width limited by T_{JM}		540	A	
V_{SD}	$I_F = 50 \text{ A}, V_{GS} = 0 \text{ V}$, Note 1		1.0	V	
t_{rr}	$I_F = 25 \text{ A}, -di/dt = 100 \text{ A}/\mu\text{s}$ $V_R = 40 \text{ V}, V_{GS} = 0 \text{ V}$	55		ns	

Notes: 1. Pulse test: $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2 \%$;
 2. Drain and Source Kelvin contacts must be located less than 5 mm from the plastic body.

ADVANCE TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

ISOPLUS i5-Pak™ (IXTL) Outline

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.190	.205	4.83	5.21
A1	.102	.118	2.59	3.00
A2	.046	.055	1.17	1.40
b	.045	.055	1.14	1.40
b1	.063	.072	1.60	1.83
b2	.100	.110	2.54	2.79
b3	.058	.068	1.47	1.73
c	.020	.029	0.51	0.74
D	1.020	1.040	25.91	26.42
E	.770	.799	19.56	20.29
e	.150	BSC	3.81	BSC
L	.780	.820	19.81	20.83
L1	.080	.102	2.03	2.59
Q	.210	.235	5.33	5.97
Q1	.490	.513	12.45	13.03
R	.150	.180	3.81	4.57
R1	.100	.130	2.54	3.30
S	.668	.690	16.97	17.53
T	.801	.821	20.34	20.85
U	.065	.080	1.65	2.03

Note:

1. TAB 6 - Electrically isolated from the other pins.
2. All leads and tab are tin plated.

IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 one or more of the following U.S. patents: 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537